

<b>Notice of References Cited</b>	Application/Control No. 10/728,757	Applicant(s)/Patent Under Reexamination YAUNG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,914,301	04-1990	Akai, Yoshimi	250/370.01
	B	US-6,246,081	06-2001	Abe, Hideshi	257/294
	C	US-5,583,354	12-1996	Ishibe, Shouichi	257/232
	D	US-6,452,186	09-2002	Wieczorek et al.	250/370.11
	E	US-5,796,154	08-1998	Sano et al.	257/432
	F	US-6,362,513	03-2002	Wester, Neil S.	257/432
	G	US-6,800,838	10-2004	Yamamoto, Katsumi	250/214R
	H	US-6,518,640	02-2003	Suzuki et al.	257/432
	I	US-5,994,751	11-1999	Oppermann, Klaus-Gunter	257/446
	J	US-5,430,298	07-1995	Possin et al.	250/370.11
	K	US-6,379,992	04-2002	Jo, Wan-Hee	438/70
	L	US-4,982,096	01-1991	Fujii et al.	250/367
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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